Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-028001	Application No. 09/833,674
	closure State/pent	Applicant Shunpei YAMAZAK	(I et al.
(Use several st	neets if necessary) IN 23	April 13, 2001	Group Art Unit 2621

	U.S. Patent Documents						
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	Other Documents (include Author, Title, Date, and Place of Publication)							
Examiner Initial	Desig. ID	Document						
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	AR							
	AS							
	AT							

Examiner Signature 3. 11	Date Considered 1/21/05
EXAMINER: Initials citation considered. Draw line through citation if no	ot in conformance and not considered. Include copy of this form with

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Substitute Form PTO-1449
(Modified)
U.S. Separtment of Made Management and Trader
Information Disclosure Statement

U.S. Separtment of Commerce

Attorney's Docket No. 12732-028001

Application No. 09/833,674

by Applicant (Use several sheets if necessary)

Applicant

Shunpei YAMAZAKI et al.

Filing Date

Group Art Unit

(37 CFR §1.98(b))

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Initial	_ 1D	<u>Document</u>				
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